

MOSFET - N-Channel Shielded Gate POWERTRENCH®

150 V, 2.8 A, 128 m Ω

FDT86244

Description

This N-Channel MOSFET is produced using Fairchild onsemi advanced PowerTrench® process that incorporates Shielded Gate technology. This process has been optimized for $R_{DS(on)}$, switching performance and ruggedness.

Features

- Shielded Gate MOSFET Technology
- Max $R_{DS(on)} = 128 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 2.8 \text{ A}$
- Max $R_{DS(on)} = 178 \text{ m}\Omega$ at $V_{GS} = 6 \text{ V}$, $I_D = 2.4 \text{ A}$
- High Performance Trench Technology for Extremely Low R_{DS(on)}
- High Power and Current Handling Capability in a Widely Used Surface Mount Package
- Fast Switching Speed
- 100% UIL Tested
- These Devices are Pb-Free and are RoHS Compliant

Typical Applications

- Load Switch
- Primary Switch

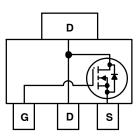
MOSFET Maximum Ratings T_A = 25°C unless otherwise noted

Symbol	Parameter	Ratings	Unit
V _{DS}	Drain to Source Voltage	150	V
V _{GS}	Gate to Source Voltage	20	V
I _D	Drain Current –Continuous T _A = 25°C (Note 1a)	2.8	Α
	-Pulsed	12	
E _{AS}	Single Pulse Avalanche Energy (Note 3)	12	mJ
P _D	Power Dissipation T _A = 25°C (Note 1a)	2.2	W
	Power Dissipation T _A = 25°C (Note 1b)	1.0	
T _J , T _{STG}	Operating and Storage Junction Temperature Range	-55 to +150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



SOT-223 CASE 318H



MARKING DIAGRAM



Z = Assembly Plan Code XY = Date Code (Year & week) 86244 = Specific Device Code

ORDERING INFORMATION

Device	Package	Shipping [†]
FDT86244	SOT-223 (Pb-Free)	4000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, <u>BRD8011/D</u>.

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THERMAL CHARACTERISTICS

Symbol	Parameter	Value	Unit
$R_{ heta JC}$	Thermal Resistance, Junction to Case (Note 1)	12	°C/W
$R_{ hetaJA}$	Thermal Resistance, Junction to Ambient (Note 1a)	55	

ELECTRICAL CHARACTERISTICS $T_A = 25^{\circ}\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
ff Characteristic	cs .					
BV_DSS	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	150	_	-	V
$\frac{\Delta \text{BV}_{\text{DSS(th)}}}{\Delta \text{T}_{\text{J}}}$	Breakdown Voltage Temperature Coefficient	I _D = 250 μA, referenced to 25°C	-	104	_	mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 120 V, V _{GS} = 0 V	-	-	1	μΑ
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$	-	_	±100	nA
n Characteristic	cs .					
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	2.0	3.1	4.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I _D = 250 μA, referenced to 25°C	-	-10	_	mV/°C
R _{DS(on)}	Static Drain to Source On Resistance	V _{GS} = 10 V, I _D = 2.8 A	-	106	128	mΩ
		V _{GS} = 6 V, I _D = 2.4 A	-	127	178	1
		V _{GS} = 10 V, I _D = 2.8 A, T _J = 125°C	-	196	237	
9 _{FS}	Forward Transconductance	V _{DS} = 10 V, I _D = 2.8 A	-	12	-	S
ynamic Charact	eristics					
C _{iss}	Input Capacitance	V _{DS} = 75 V, V _{GS} = 0 V, f =1 MHz		295	395	pF
C _{oss}	Output Capacitance		-	33	45	pF
C _{rss}	Reverse Transfer Capacitance	7	-	2.4	5	pF
R _g	Gate Resistance		-	1	-	Ω
Switching Charac	cteristics					
t _{d(on)}	Turn-On Delay Time	$V_{DD} = 75 \text{ V}, I_D = 2.8 \text{ A},$	-	5.3	11	ns
t _r	Rise Time	$V_{GS} = 10 \text{ V, } R_{GEN} = 6 \Omega$	-	1.3	10	ns
t _{d(off)}	Turn-Off Delay Time		-	9.8	20	ns
t _f	Fall Time	7	-	2.4	10	ns
Q _{g(TOT)}	Total Gate Charge	V _{GS} = 0 V to 10 V,	-	4.9	7	nC
Q _{g(TOT)}	Total Gate Charge	$V_{GS} = 0 \text{ V to 5 V}$	-	2.8	4	nC
Q _{gs}	Total Gate Charge	V _{DD} = 75 V,	-	1.4	-	nC
Q _{gd}	Gate to Drain "Miller" Charge	I _D = 2.8 A	_	1.3	-	nC

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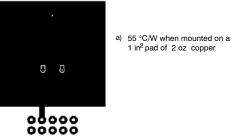
ELECTRICAL CHARACTERISTICS (continued) $T_A = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
Drain-Source Diode Characteristics						
V _{SD}	Source to Drain Diode Forward Voltage	V _{GS} = 0 V, I _S = 2.8 A (Note 2)	-	0.82	1.3	V
t _{rr}	Reverse Recovery Time	$I_F = 2.8 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}$	-	48	77	ns
Q_{rr}	Reverse Recovery Charge		-	44	70	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

NOTES:

1. $R_{\theta JA}$ is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.

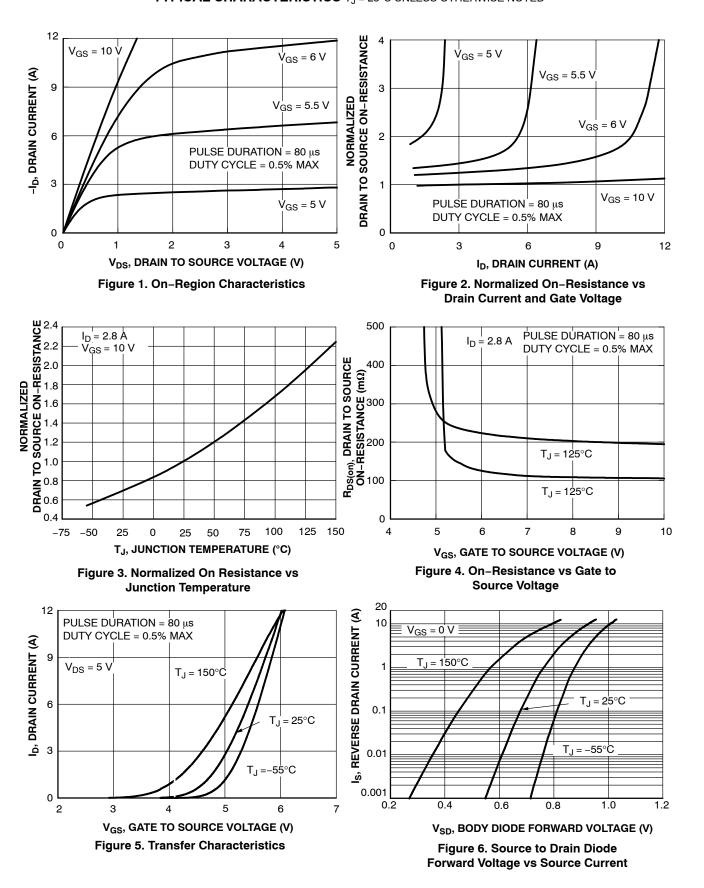




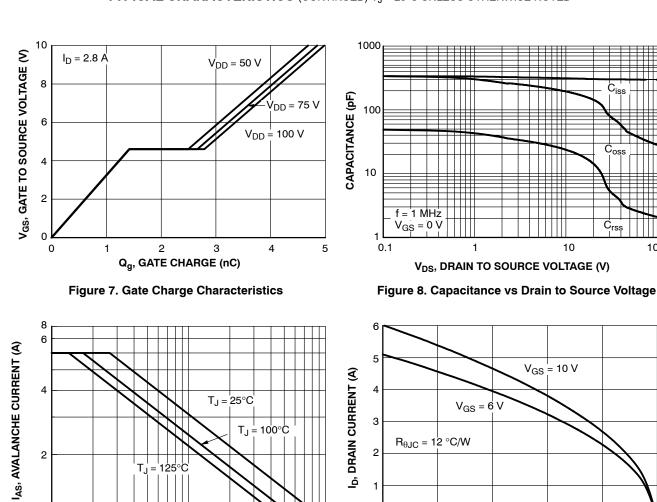
b) 118 °C/W when mounted on a minimum pad of 2 oz copper

- 2. Pulse Test : Pulse Width < 300 μs , Duty Cycle < 2.0% 3. Starting T $_J$ = 25 $^{\circ}C$; N–ch: L = 1 mH, I $_{AS}$ = 5 A, V $_{DD}$ = 135 V, V $_{GS}$ = 10 V.

TYPICAL CHARACTERISTICS T_{.J} = 25°C UNLESS OTHERWISE NOTED



TYPICAL CHARACTERISTICS (CONTINUED) T, = 25°C UNLESS OTHERWISE NOTED



t_{AV}, TIME IN AVALANCHE (ms) Figure 9. Unclamped Inductive Switching

0.1

0.01

20

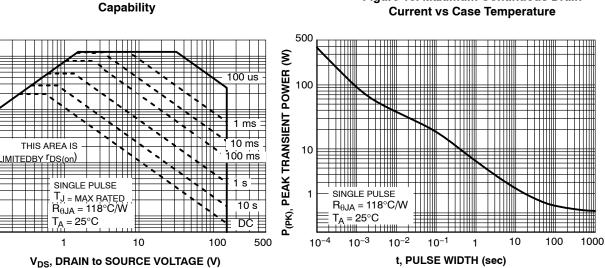
10

ID, DRAIN CURRENT (A)

0.01

0.005

0.1



₀ L

50

Figure 11. Forward Bias Safe Operating Area

Figure 12. Single Pulse Maximum Power Dissipation

100

V_{GS} = 10 V

100

T_C, CASE TEMPERATURE (°C)

Figure 10. Maximum Continuous Drain

75

125

150

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TYPICAL CHARACTERISTICS (CONTINUED) $T_J = 25^{\circ}C$ UNLESS OTHERWISE NOTED

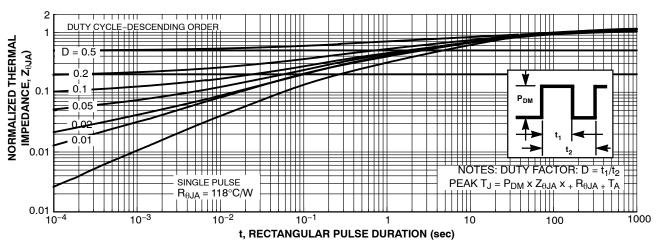
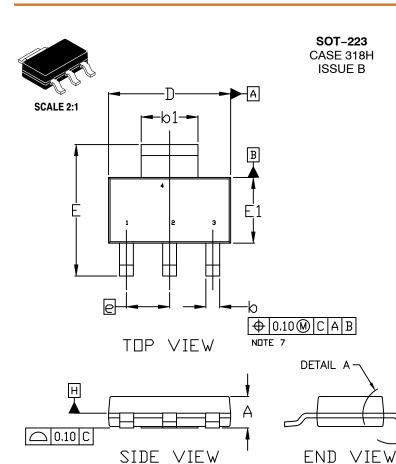


Figure 13. Junction-to-Ambient Transient Thermal Response Curve





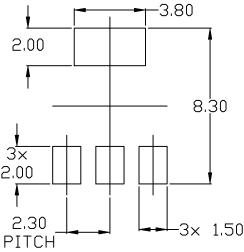
DATE 13 MAY 2020

NUTES:

- DIMENSIONING AND TOLERANCING PER ASME
- DIMENSIDNING AND TOLERANCING PER ASME Y14.5M, 2009.
 CONTROLLING DIMENSION: MILLIMETERS DIMENSIONS D & E1 ARE DETERMINED AT DATUM H. DIMENSIONS DO NOT INCLUDE MOLD FLASH, PROTRUSIONS DR GATE BURRS. SHALL NOT EXCEED 0.23mm PER SIDE.
 LEAD DIMENSIONS & AND &1 DO NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBBAR PROTRUSION. ALLOWABLE DAMBBAR PROTRUSION IS 0.08mm PER SIDE.
 DATUMS A AND B ARE DETERMINED AT DATUM H. A1 IS DEFINED AS THE VERTICAL DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT OF THE PACKAGE BODY.
 POSITIONAL TOLERANCE APPLIES TO DIMENSIONS & AND &1.

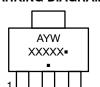
- b AND b1.

	MILLIMETERS			
DIM	MIN.	N□M.	MAX.	
Α			1.80	
A1	0.02	0.06	0.11	
b	0.60	0.74	0.88	
b1	2.90	3.00	3.10	
С	0.24		0.35	
D	6.30	6.50	6.70	
E	6.70	7.00	7.30	
E1	3.30	3.50	3.70	
е	2.30 BSC			
L	0.25			
Ż	0*		10°	



GENERIC MARKING DIAGRAM*

A1



= Assembly Location

Υ = Year

DETAIL A

W = Work Week

XXXXX = Specific Device Code

= Pb-Free Package

(Note: Microdot may be in either location)

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

RECOMMENDED MOUNTING FOOTPRINT

For additional information on our Pb-Free strategy and soldering details, please download the IIN Semiconductor Soldering and Mounting Techniques Reference Manual, SILDERRM/D.

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DESCRIPTION:	SOT-223		PAGE 1 OF 1	

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